Preferred Devices

Silicon Power Transistors

The MJW21195 and MJW21196 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain -

 $h_{FE} = 20 \text{ Min } @ I_{C} = 8 \text{ Adc}$

- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	VCEO	250	Vdc
Collector–Base Voltage	VCBO	400	Vdc
Emitter-Base Voltage	VEBO	5.0	Vdc
Collector–Emitter Voltage – 1.5 V	VCEX	400	Vdc
Collector Current – Continuous – Peak (Note 1)	lC	16 30	Adc
Base Current – Continuous	ΙΒ	5.0	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	PD	200 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	Т _J , T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	0.7	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	40	°C/W

^{1.} Pulse Test: Pulse Width = 5 μ s, Duty Cycle \leq 10%.



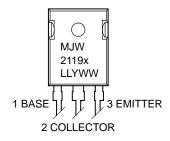
ON Semiconductor™

http://onsemi.com

16 AMPERES
COMPLEMENTARY
SILICON POWER
TRANSISTORS
250 VOLTS
200 WATTS



MARKING DIAGRAM



MJW2119x = Device Code

= 5 or 6

LL = Location Code

Y = Year

WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping
MJW21195	TO-247	30 Units/Rail
MJW21196	TO-247	30 Units/Rail

Preferred devices are recommended choices for future use and best overall value.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS						
Collector–Emitter Sustaining Voltage (I _C = 100 mAdc, I _B = 0)		VCEO(sus)	250	-	-	Vdc
Collector Cutoff Current (V _{CE} = 200 Vdc, I _B = 0)		ICEO	_	-	100	μAdc
ELECTRICAL CHARACTERISTICS (T _C = 25°C ur	nless otherwise note	ed)				
Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS						
Emitter Cutoff Current (V _{CE} = 5 Vdc, I _C = 0)		IEBO	_	_	50	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)		ICEX	_	-	50	μAdc
SECOND BREAKDOWN						
Second Breakdown Collector Current with Base Forward Biased (V _{CE} = 50 Vdc, t = 1 s (non–repetitive) (V _{CE} = 80 Vdc, t = 1 s (non–repetitive)		I _{S/b}	4.0 2.25		- -	Adc
ON CHARACTERISTICS		•		•		•
DC Current Gain (IC = 8 Adc, VCE = 5 Vdc) (IC = 16 Adc, IB = 5 Adc)		hFE	20 8	_ _	80 -	
Base–Emitter On Voltage (I _C = 8 Adc, V _{CE} = 5 Vdc)		V _{BE(on)}	-	-	2.0	Vdc
Collector–Emitter Saturation Voltage (I _C = 8 Adc, I _B = 0.8 Adc) (I _C = 16 Adc, I _B = 3.2 Adc)		VCE(sat)	_ _	- -	1.0	Vdc
DYNAMIC CHARACTERISTICS						
Total Harmonic Distortion at the Output VRMS = 28.3 V, f = 1 kHz, PLOAD = 100 WRMS	hFE unmatched	T _{HD}	_	0.8	1	%
(Matched pair hFE = 50 @ 5 A/5 V)	hFE matched		_	0.08	-	
Current Gain Bandwidth Product (I _C = 1 Adc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)		fT	4	_	-	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)		C _{ob}		_	500	pF

PNP MJW21195

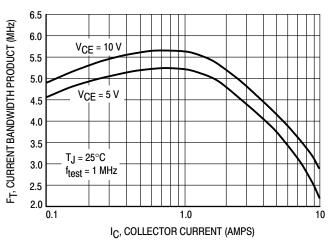


Figure 1. Typical Current Gain **Bandwidth Product**

NPN MJW21196

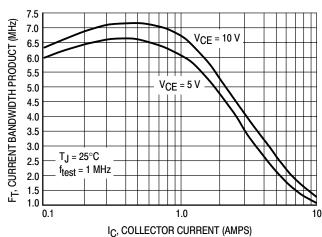


Figure 2. Typical Current Gain **Bandwidth Product**

TYPICAL CHARACTERISTICS

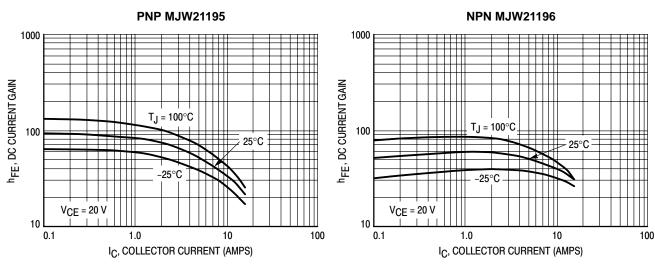


Figure 3. DC Current Gain, V_{CE} = 20 V

Figure 4. DC Current Gain, V_{CE} = 20 V

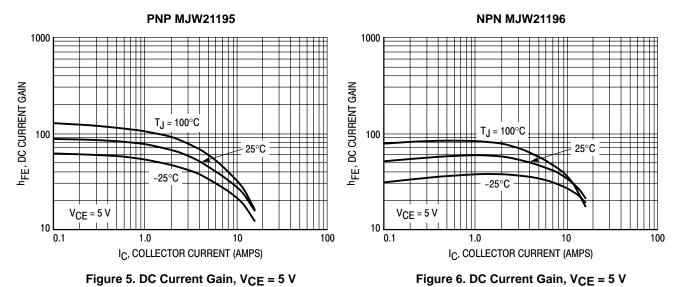


Figure 5. DC Current Gain, V_{CE} = 5 V

PNP MJW21195 NPN MJW21196 30 30 2.0 A 2.0 A 1.5 A 25 25 I_C, COLLECTOR CURRENT (A) IC, COLLECTOR CURRENT (A) 1.5 A 1.0 A 1.0 A 20 20 $I_B = 0.5 A$ $I_B = 0.5 A$ 15 15 10 10 5.0 5.0 $T_J = 25^{\circ}C$ $T_J=25^{\circ}C$ 0 0 10 15 25 15 20 0 25 VCE, COLLECTOR-EMITTER VOLTAGE (VOLTS) VCE, COLLECTOR-EMITTER VOLTAGE (VOLTS)

Figure 7. Typical Output Characteristics

Figure 8. Typical Output Characteristics

TYPICAL CHARACTERISTICS

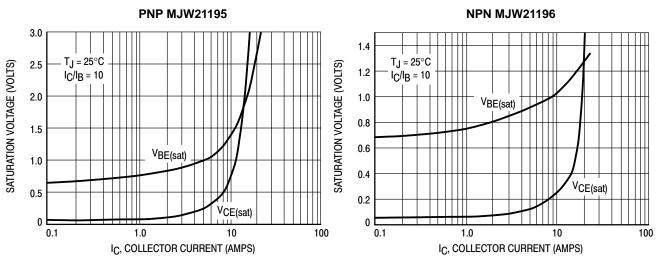


Figure 9. Typical Saturation Voltages

Figure 10. Typical Saturation Voltages

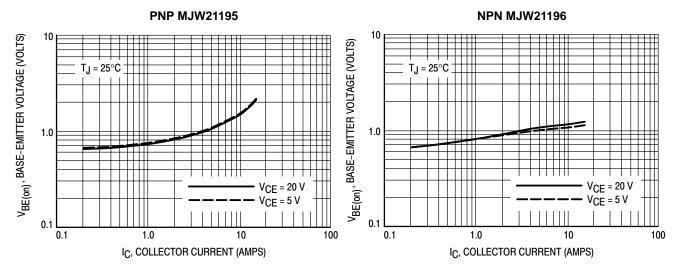


Figure 11. Typical Base-Emitter Voltage

Figure 12. Typical Base-Emitter Voltage

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 150$ °C; T_{C} is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

TYPICAL CHARACTERISTICS

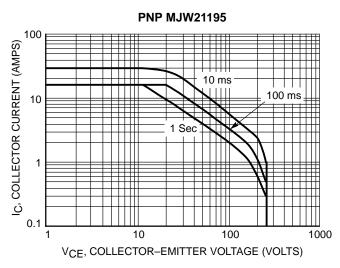


Figure 13. Active Region Safe Operating Area

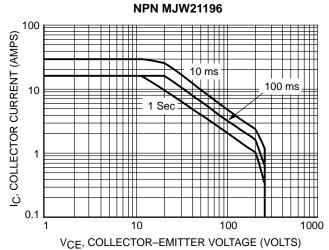


Figure 14. Active Region Safe Operating Area

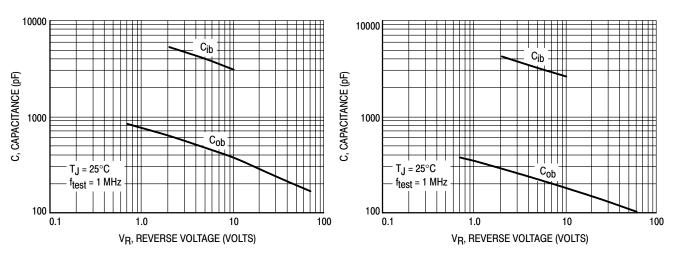


Figure 15. MJW21195 Typical Capacitance

Figure 16. MJW21196 Typical Capacitance

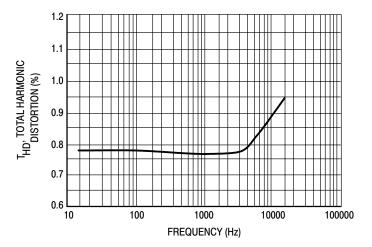


Figure 17. Typical Total Harmonic Distortion

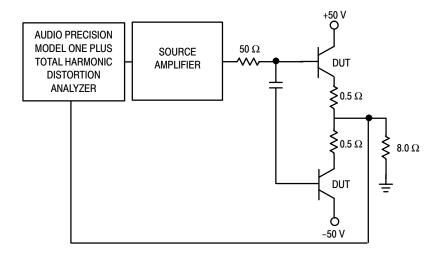
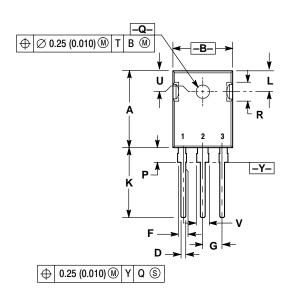
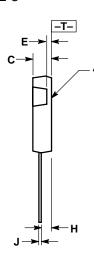


Figure 18. Total Harmonic Distortion Test Circuit

PACKAGE DIMENSIONS

TO-247 CASE 340K-01 ISSUE C





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN MAX		
Α	19.7	20.3	0.776	0.799	
В	15.3	15.9	0.602	0.626	
С	4.7	5.3	0.185	0.209	
D	1.0	1.4	0.039	0.055	
Е	1.27 REF		0.050 REF		
F	2.0	2.4	0.079	0.094	
G	5.5 BSC		0.216 BSC		
Н	2.2	2.6	0.087	0.102	
J	0.4	0.8	0.016	0.031	
K	14.2	14.8	0.559	0.583	
L	5.5 NOM		0.217 NOM		
Р	3.7	4.3	0.146	0.169	
Q	3.55	3.65	0.140	0.144	
R	5.0 NOM		0.197 NOM		
U	5.5 BSC		0.217 BSC		
٧	3.0	3.4	0.118	0.134	

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